

Search Notes**Application/Control No.**

10/609,452

Examiner

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Applicant(s)/Patent under Reexamination

HE ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	592.1 605 830-832 846 854	10/20/2005	PK
174	52.1 255		
	260 261		
607	1-3 46-52		
	59-61		
600	302 554 377		
127	877	↓	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST/NPL (IEEE)	10/26/2005	PK
Updated Text Search East	4/5/2006	PK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner